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L1	483	(display) near20 (network subnetwork) near20 (address) near10 (tree pie information grid)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:51
L2	13	(display) near20 (network subnetwork) near20 (address) near10 (tree grid)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:39
L3	14	(display) near20 (network subnetwork) near20 (address) near10 (tree pie information grid) and ((mask) near10 (address))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:52
L4	0	(controlling manag\$5 render\$5) near15 (display) near20 (network subnetwork) near20 (address) near10 (highlight\$5 annotat\$5) near20 (mask origin) near20 (address)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:54
L5	0	(controlling manag\$5 render\$5) near15 (display) near20 (network subnetwork) near20 (address) near10 (highlight\$5 annotat\$5) near20 (mask origin)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:54
L6	0	(display) near20 (network subnetwork) near20 (address) near10 (highlight\$5 annotat\$5) near20 (mask origin)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:54
L7	0	(controlling manag\$5 render\$5) near15 (display) near20 (network subnetwork) near20 (address) near10 (highlight\$5 annotat\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 10:55
L8	8	(display) near20 (network subnetwork) near20 (address) near10 (highlight\$5 annotat\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:01
L9	1	(highlight\$5 annotat\$5) near20 (network subnetwork) near20 (address) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:02
L10	0	(setting set render\$5) near10 (boundary border highlight indicator box) near10 (dsplay presentation) same (network subnetwork) near10 (device element address unit system node) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:06
L11	0	(boundary border highlight indicator box) near10 (dsplay presentation) same (network subnetwork) near10 (device element address unit system node) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:06

L12	3	(boundary border highlight indicator box) near10 (display presentation) same (network subnetwork) near10 (device element address unit system node) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:08
L13	1	(boundary border highlight indicator box) near10 (selected chosen predicted) same (network subnetwork) near10 (device element address unit system node) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:12
L14	35	(highlight) near10 (selected chosen predicted) same (network subnetwork) near10 (device element address unit system node)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:24
L15	6605789	(group\$5 collect\$5 combin\$5 gater\$5) (network subnetwork) near10 (device element node) near10 (based depend\$5 analy\$7) near10 (address\$5) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:26
L16	0	(group\$5 collect\$5 combin\$5 gater\$5) near10 (network subnetwork) near10 (device element node) near10 (based depend\$5 analy\$7) near10 (address\$5) near10 (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:27
L17	75	(group\$5 collect\$5 combin\$5 gater\$5) near10 (network subnetwork) near10 (device element node) near10 (based depend\$5 analy\$7) near10 (address\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:28
L18	120	(group\$5 collect\$5 combin\$5 gater\$5 search\$5) near10 (network subnetwork) near10 (device element node) near10 (based depend\$5 analy\$7) near10 (address\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 11:50
L19	70	(group\$5 collect\$5 combin\$5 gater\$5 search\$5) near10 (network subnetwork) near10 (device element node) near20 (mask\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:04
L20	34	(group\$5 collect\$5 combin\$5 gater\$5 search\$5) near10 (network subnetwork) near10 (device element node) near20 (address\$5) near10 (mask\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:13
L21	110538	(group\$5 collect\$5 gater\$5) near10 (display\$5 present\$5)(network) near10 (device element node) near20 (address\$5) adj10 (mask\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:15
L22	0	(group\$5 collect\$5 gater\$5) near10 (display\$5 present\$5) near10 (network) near10 (device element node) near20 (address\$5) adj10 (mask\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:16

L23	1	(display\$5 present\$5) near10 (network) near10 (device element node) near20 (address\$5) adj10 (mask\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:40
L24	0	"715"/\$.ccls. and ((controlling) near5 (display pixel) near5 (network\$5) near5 (address\$5) near5 (mask))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:41
L25	0	"715"/\$.ccls. and ((controlling) near5 (pixel grid) near5 (network\$5) near5 (address\$5) near5 (mask))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:42
L26	15	(determin\$5)near10 (address\$5) near5 (mask) near20 (size)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 12:55
L27	0	(determin\$5)near10 (device node) near5(address\$5) near5 (mask) near20 (size)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 14:14
L28	60	715/700,711,713,735,736,737,738,742,853,859,521,512,513,514.ccls. and ((determin\$5 decid\$5 calculat\$5 comput\$5 set\$5) near5 (border boundary limit outlin\$5) near5 (display window))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 14:25
L29	2	715/700,711,713,735,736,737,738,742,853,859,521,512,513,514.ccls. and ((determin\$5 decid\$5 calculat\$5 comput\$5 set\$5) near5 (border boundary limit outlin\$5) near5 (display window)) and (network\$5) near3 (address)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 14:39
L30	4	715/736.ccls. and ((display window) near5 (network\$5) near3 (address))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:46
L31	2	"6404444".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 14:48
L32	0	345/589,613,614,612,626,628,563,564,699.ccls. and ((display window) near5 (network\$5) near3 (address))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:59
L33	5	345/589,613,614,612,626,628,563,564,699.ccls. and (network\$5) near3 (address)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:47

L34	673	"709"/\$.ccls. and (display) near20 (address) near10 (tree pie information grid)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:52
L35	11	"709"/\$.ccls. and (display) near20 (address) near10 (tree pie information grid) and (mask) near4 (size bit squad)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 15:53
L36	0	345/589,613,614,612,626,628,563,564,699.ccls. and (generat\$5 creat\$5 build\$5) near4 (network\$5) near4 (status information address data) near4 (display)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 16:01
L37	297	(generat\$5 creat\$5 build\$5) near4 (network\$5) near4 (status information address data) near4 (display)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 16:04
L38	1	(generat\$5 creat\$5 build\$5) near4 (network\$5) near4 (status information address data) near4 (display) same (mask)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 16:04
L39	297	(generat\$5 creat\$5 build\$5) near4 (network\$5) near4 (status information address data) near4 (display)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/08 16:04
S27	33277	(Optical near5 channel)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 16:57



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1 Sampled grating DBR laser as a spectroscopic source in multigas detection at 1.52-1.57 μm

Boylan, K.; Weldon, V.; McDonald, D.; O'Gorman, J.; Hegarty, J.;
Optoelectronics, IEE Proceedings- , Volume: 148 , Issue: 1 , Feb 2001
Pages:19 - 24

[\[Abstract\]](#) [\[PDF Full-Text \(688 KB\)\]](#) **IEE JNL**

2 Simulation Modeling Requirements for Determining Soldier Tactical Mission System Effectiveness

Tollefson, E.S.; Kwinn, M.J.; Martin, P.G.; Boylan, G.L.; Foote, B.L.;
Simulation Conference, 2004. Proceedings of the 2004 Winter , Volume:
1 , December 5-8, 2004
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3 Utilizing dcom in an open system architecture framework for machine monitoring and diagnostics

Lebold, M.; Reichard, K.; Boylan, D.;
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4 A sampled grating distributed Bragg reflector laser diode for spectroscopic based multi-gas detection at 1.5 μm

Boylan, K.; Weldon, V.; McDonald, D.; Rawsthorne, J.; Ogorman, J.O.; Hegari
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5 **Mobius: a case study [reverse technology transfer]**

Knoth, W.H., Jr.; Boylan, R.; Walsh, S.;
Engineering Management Society, 2000. Proceedings of the 2000 IEEE , 13-11
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6 **Key success factors affecting choice in an emergent technology base**

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'97: Portland International Conference on Management and Technology , 27-3
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7 **Differences in technology management practice in Northern China**

Simons, G.; Boylan, R.; Lucarelli, C.; Wright, F.; Knoth, W.; Tan, A.; Walsh, S
Innovation in Technology Management - The Key to Global Leadership. PICME
'97: Portland International Conference on Management and Technology , 27-3
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8 **Linking manufacturing acquisition strategies with firm success: evidence from the semiconductor silicon industry**

Walsh, S.T.; McDermott, C.; Boylan, R.;
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9 **Operational Manned Vehicles of the Soviet Union**

Boylan, L.;
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10 **Widely tunable twin fiber grating dispersion compensator for 80 Gb/s**

*Fells, J.A.J.; Bennett, P.J.; Feced, R.; Ayliffe, P.; Wakefield, J.; Priddle, H.F.M.
Baker, V.; Kanellopoulos, S.E.; Boylan, C.; Sahil, S.; Lee, W.S.; Clements, S.;*
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11 Measuring success in breakthrough

Dermott, C.M.; Boylan, R.;

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12 Developing technological entrepreneurship in China

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13 Power-on contention: a reliability issue for logic devices

Muniandy, R.; Miller, S.; Lim Yew Tee; Boylan, R.;

Physical and Failure Analysis of Integrated Circuits, 1995., Proceedings of the 5th International Symposium on the , 27 Nov.-1 Dec. 1995

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14 Band pass current control

Rozman, A.F.; Boylan, J.J.;

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Document Analysis and Recognition, 2001. Proceedings. Sixth International Conference on , 10-13 Sept. 2001

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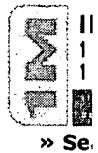
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1 A multiprocessor-based controller for the control of mechanical manipulators
Nigam, R.; Lee, C.G.;

Robotics and Automation, IEEE Journal of [legacy, pre - 1988] , Volume: 1 , Issue: 4 , Dec 1985

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2 Measuring the Management of Estuarine Waters
Burroughs, R.; Lee, V.;

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3 A 32b CMOS single-chip RISC type processor
Marston, A.; Burroughs, G.; Chen, K.-C.; Al Desroches; Emerson, G.; Hsu, J.; R.; Najami, F.; Peebles, A.; Peterson, K.; Saperstein, B.; Wangunhardjo, J.; Wiemann, A.; Wu, R.;

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1 SNA Function Management
Hoberecht, V.;

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Pages:594 - 603

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